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Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of Embedded - Microprocessors

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details	
Product Status	Active
Core Processor	PowerPC e300c3
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	400MHz
Co-Processors/DSP	Security; SEC 3.3
RAM Controllers	DDR, DDR2
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (2)
SATA	-
USB	USB 2.0 + PHY (1)
Voltage - I/O	1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	Cryptography, Random Number Generator
Package / Case	620-BBGA Exposed Pad
Supplier Device Package	620-PBGA (29x29)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=kmpc8314evragda

2.9 Dual Enhanced Three-Speed Ethernet Controllers (eTSECs)

The eTSECs include the following features:

- Two SGMII/RGMII/MII/RMII/RTBI interfaces
- Two controllers designed to comply with IEEE Std 802.3™, IEEE 802.3u™, IEEE 802.3x™, IEEE 802.3z™, IEEE 802.3au™, IEEE 802.3ab™, and IEEE Std 1588™
- Support for Wake-on-Magic Packet™, a method to bring the device from standby to full operating mode
- MII management interface for external PHY control and status.

2.10 Integrated Programmable Interrupt Controller (IPIC)

The integrated programmable interrupt controller (IPIC) provides a flexible solution for general-purpose interrupt control. The IPIC programming model is compatible with the MPC8260 interrupt controller and supports external and internal discrete interrupt sources. Interrupts can also be redirected to an external interrupt controller.

2.11 Power Management Controller (PMC)

The MPC8314E supports a range of power management states that significantly lower power consumption under the control of the power management controller. The PMC includes the following features:

- Provides power management when the device is used in both PCI host and agent modes
- PCI Power Management 1.2 D0, D1, D2, D3hot, and D3cold states
- PME generation in PCI agent mode, PME detection in PCI host mode
- Wake-up from Ethernet (magic packet), USB, GPIO, and PCI (PME input as host) while in the D1, D2 and D3hot states
- A new low-power standby power management state called D3warm
  - The PMC, one Ethernet port, and the GTM block remain powered via a split power supply controlled through an external power switch
  - Wake-up events include Ethernet (magic packet), GTM, GPIO, or IRQ inputs and cause the device to transition back to normal operation
  - PCI agent mode is not be supported in D3warm state
- PCI Express-based PME events are not supported

2.12 Serial Peripheral Interface (SPI)

The serial peripheral interface (SPI) allows the MPC8314E to exchange data between other PowerQUICC family chips, Ethernet PHYs for configuration, and peripheral devices such as EEPROMs, real-time clocks, A/D converters, and ISDN devices.

The SPI is a full-duplex, synchronous, character-oriented channel that supports a four-wire interface (receive, transmit, clock, and slave select). The SPI block consists of transmitter and receiver sections, an independent baud-rate generator, and a control unit.

2.13 DMA Controller, I^{2}C, DUART, Enhanced Local Bus Controller (eLBC), and Timers

The integrated four-channel DMA controller includes the following features:

- Allows chaining (both extended and direct) through local memory-mapped chain descriptors (accessible by local masters)
- Misaligned transfer capability for source/destination address
- Supports external DREQ, DACK and DONE signals

There is one I^{2}C controller. This synchronous, multi-master buses can be connected to additional devices for expansion and system development.

The DUART supports full-duplex operation and is compatible with the PC16450 and PC16550 programming models. 16-byte FIFOs are supported for both the transmitter and the receiver.

The eLBC port allows connections with a wide variety of external DSPs and ASICs. Three separate state machines share the same external pins and can be programmed separately to access different types of devices. The general-purpose chip select machine (GPCM) controls accesses to asynchronous devices using a simple handshake protocol. The three user programmable machines (UPMs) can be programmed to interface to synchronous devices or custom ASIC interfaces. Each chip select can be configured so that the associated chip interface can be controlled by the GPCM or UPM controller. Both may exist in the same system. The local bus can operate at up to 66 MHz.

The system timers include the following features: periodic interrupt timer, real time clock, software watchdog timer, and two general-purpose timer blocks.

3 Electrical Characteristics

This section provides the AC and DC electrical specifications and thermal characteristics for the MPC8314E, which is currently targeted to these specifications. Some of these specifications are independent of the I/O cell, but they are included for complete reference. These are not purely I/O buffer design specifications.

3.1 Overall DC Electrical Characteristics

This section covers the ratings, conditions, and other characteristics.

3.1.1 Absolute Maximum Ratings

This table provides the absolute maximum ratings.

Table 1. Absolute Maximum Ratings [1]

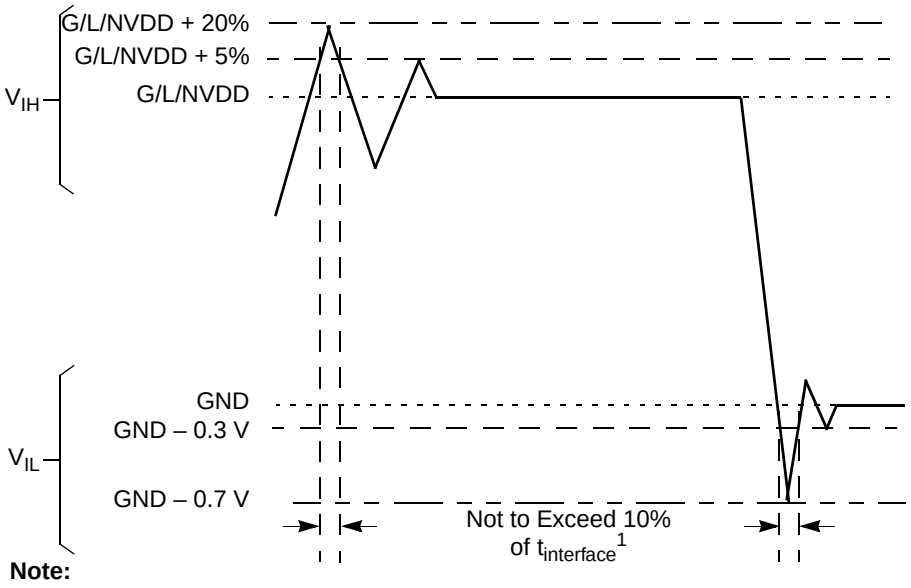
Characteristic	Symbol	Max Value	Unit	Note
Core supply voltage	VDD	–0.3 to 1.26	V	—
PLL supply voltage	AVDD	–0.3 to 1.26	V	—
DDR1 DRAM I/O supply voltage	GVDD	–0.3 to 2.7	V	—

Table 2. Recommended Operating Conditions (continued)

Characteristic	Symbol	Recommended Value[1]	Unit	Status in D3 Warm mode	Note

Note:
1. The NVDDx_ON are static power supplies and can be connected together.
2. The NVDDx_OFF are switchable power supplies and can be connected together.
3. Minimum Temperature is specified with T_A;maximum temperature is specified with T_J.
4. All Power rails must be connected and power applied to the MPC8314 even if the IP interfaces are not used.
5. All I/O pins should be interfaced with peripherals operating at same voltage level.
6. This voltage is the input to the filter discussed in Section 25.2, "PLL Power Supply Filtering" and not necessarily the voltage at the AVDD pin.
7. All 1V power supplies should be derived from the same source.

This figure shows the undershoot and overshoot voltages at the interfaces of the MPC8314E.



Note:
1. $t_{interface}$ refers to the clock period associated with the bus clock interface.

Figure 2. Overshoot/Undershoot Voltage for GVDD/NVDD/LVDD

3.1.3 Output Driver Characteristics

This table provides information on the characteristics of the output driver strengths. The values are preliminary estimates.

Table 3. Output Drive Capability

Driver Type	Output Impedance (Ω)	Supply Voltage
Local bus interface utilities signals	42	NVDD = 3.3 V
PCI signals	25	
DDR signal[1]	18	GVDD = 2.5 V
DDR2 signal 1	18	GVDD = 1.8 V

Table 9. RESET Initialization Timing Specifications (continued)

Note:
1. $t_{PCI\_SYNC\_IN}$ is the clock period of the input clock applied to PCI_SYNC_IN. When the device is In PCI host mode the primary clock is applied to the SYS_CLK_IN input, and PCI_SYNC_IN period depends on the value of CFG_SYS_CLKIN_DIV.
2. $t_{SYS\_CLK\_IN}$ is the clock period of the input clock applied to SYS_CLK_IN. It is only valid when the device is in PCI host mode.
3. POR configuration signals consists of CFG_RESET_SOURCE[0:3] and CFG_SYS_CLKIN_DIV.
4. The parameter names CFG_SYS_CLKIN_DIV and CFG_CLKIN_DIV are used interchangeably in this document.

This table provides the PLL lock times.

Table 10. PLL Lock Times

Parameter/Condition	Min	Max	Unit	Note
System PLL lock times	—	100	μs	—
e300 core PLL lock times	—	100	μs	—
SerDes (SGMII/PCI Exp Phy) PLL lock times	—	100	μs	—
USB phy PLL lock times	—	100	μs	—

7 DDR and DDR2 SDRAM

This section describes the DC and AC electrical specifications for the DDR SDRAM interface of the MPC8314E. Note that DDR SDRAM is GVDD(typ) = 2.5 V and DDR2 SDRAM is GVDD(typ) = 1.8 V.

7.1 DDR and DDR2 SDRAM DC Electrical Characteristics

This table provides the recommended operating conditions for the DDR2 SDRAM component(s) of the MPC8314E when GVDD(typ) = 1.8 V.

Table 11. DDR2 SDRAM DC Electrical Characteristics for GVDD(typ) = 1.8 V

Parameter/Condition	Symbol	Min	Max	Unit	Note
I/O supply voltage	GVDD	1.7	1.9	V	1
I/O reference voltage	MVREF	0.49 × GVDD	0.51 × GVDD	V	2
I/O termination voltage	V_{TT}	MVREF – 0.04	MVREF + 0.04	V	3
Input high voltage	V_{IH}	MVREF+ 0.125	GVDD + 0.3	V	—
Input low voltage	V_{IL}	–0.3	MVREF – 0.125	V	—
Output leakage current	I_{OZ}	–9.9	9.9	μA	4
Output high current (V_{OUT} = 1.420 V, GVDD= 1.7V)	I_{OH}	–13.4	—	mA	—
Output low current (V_{OUT} = 0.280 V)	I_{OL}	13.4	—	mA	

Note:
1. GVDD is expected to be within 50 mV of the DRAM GVDD at all times.
2. MVREF is expected to be equal to 0.5 × GVDD, and to track GVDD DC variations as measured at the receiver. Peak-to-peak noise on MVREF may not exceed ±2% of the DC value.
3. V_{TT} is not applied directly to the device. It is the supply to which far end signal termination is made and is expected to be equal to MVREF. This rail should track variations in the DC level of MVREF.
4. Output leakage is measured with all outputs disabled, 0 V ≤ V_{OUT} ≤ GVDD.

This table provides the DDR2 capacitance when GVDD(typ) = 1.8 V.

Table 12. DDR2 SDRAM Capacitance for GVDD(typ) = 1.8 V

Parameter/Condition	Symbol	Min	Max	Unit	Note
Input/output capacitance: DQ, DQS	C_{IO}	6	8	pF	1
Delta input/output capacitance: DQ, DQS	C_{DIO}	—	0.5	pF	1

Note:
1. This parameter is sampled. GVDD = 1.8 V ± 0.090 V, f = 1 MHz, T_A = 25°C, V_{OUT} = GVDD/2, V_{OUT} (peak-to-peak) = 0.2 V.

This table provides the recommended operating conditions for the DDR SDRAM component(s) of the MPC8314E when GVDD(typ) = 2.5 V.

Table 13. DDR SDRAM DC Electrical Characteristics for GVDD(typ) = 2.5 V

Parameter/Condition	Symbol	Min	Max	Unit	Note
I/O supply voltage	GVDD	2.3	2.7	V	1
I/O reference voltage	MVREF	0.49 × GVDD	0.51 × GVDD	V	2
I/O termination voltage	V_{TT}	MVREF – 0.04	MVREF + 0.04	V	3
Input high voltage	V_{IH}	MVREF + 0.15	GVDD + 0.3	V	—
Input low voltage	V_{IL}	–0.3	MVREF – 0.15	V	—
Output leakage current	I_{OZ}	–9.9	–9.9	μA	4
Output high current (V_{OUT} = 1.95 V, GVDD = 2.3V)	I_{OH}	–16.2	—	mA	—
Output low current (V_{OUT} = 0.35 V)	I_{OL}	16.2	—	mA	—

Note:
1. GVDD is expected to be within 50 mV of the DRAM GVDD at all times.
2. MVREF is expected to be equal to 0.5 × GVDD, and to track GVDD DC variations as measured at the receiver. Peak-to-peak noise on MVREF may not exceed ±2% of the DC value.
3. V_{TT} is not applied directly to the device. It is the supply to which far end signal termination is made and is expected to be equal to MVREF. This rail should track variations in the DC level of MVREF.
4. Output leakage is measured with all outputs disabled, 0 V ≤ V_{OUT} ≤ GVDD.

This table provides the DDR capacitance when GVDD(typ) = 2.5 V.

Table 14. DDR SDRAM Capacitance for GVDD(typ) = 2.5 V Interface

Parameter/Condition	Symbol	Min	Max	Unit	Note
Input/output capacitance: DQ,DQS	C_{IO}	6	8	pF	1
Delta input/output capacitance: DQ, DQS	C_{DIO}	—	0.5	pF	1

Note:
1. This parameter is sampled. GVDD = 2.5 V ± 0.125 V, f = 1 MHz, T_A = 25°C, V_{OUT} = GVDD/2, V_{OUT} (peak-to-peak) = 0.2 V.

This table provides the current draw characteristics for MV_{REF}.

Table 15. Current Draw Characteristics for MV_{REF}

Parameter / Condition	Symbol	Min	Max	Unit	Note
Current draw for MV_{REF}	I_{MVREF}	—	500	μA	1

Table 30. MII Management DC Electrical Characteristics Powered at 3.3 V (continued)

Parameter	Symbol	Conditions		Min	Max	Unit
Input low current	I_{IL}	NVDD = Max	V_{IN} = 0.5 V	–600	—	μA

Note:
1. The symbol V_{IN}, in this case, represents the NV_{IN} symbol referenced in Table 1 and Table 2.

9.3.2 MII Management AC Electrical Specifications

This table provides the MII management AC timing specifications.

Table 31. MII Management AC Timing Specifications

At recommended operating conditions with NVDD is 3.3 V ± 300 mv

Parameter/Condition	Symbol [1]	Min	Typ	Max	Unit	Note
MDC frequency	f_{MDC}	—	2.5	—	MHz	2
MDC period	t_{MDC}	—	400	—	ns	—
MDC clock pulse width high	t_{MDCH}	32	—	—	ns	—
MDC to MDIO delay	t_{MDKHDX}	10	—	170	ns	3
MDIO to MDC setup time	t_{MDDVKH}	5	—	—	ns	—
MDIO to MDC hold time	t_{MDDXKH}	0	—	—	ns	—
MDC rise time	t_{MDCR}	—	—	10	ns	—
MDC fall time	t_{MDHF}	—	—	10	ns	—

Note:
1. The symbols used for timing specifications herein follow the pattern of $t_{\text{(first two letters of functional block)(signal)(state)(reference)(state)}}$ for inputs and $t_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$ for outputs. For example, t_{MDKHDX} symbolizes management data timing (MD) for the time t_{MDC} from clock reference (K) high (H) until data outputs (D) are invalid (X) or data hold time. Also, t_{MDDVKH} symbolizes management data timing (MD) with respect to the time data input signals (D) reach the valid state (V) relative to the t_{MDC} clock reference (K) going to the high (H) state or setup time. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
2. This parameter is dependent on the csb_clk speed (that is, for a csb_clk of 133 MHz, the maximum frequency is 4.16 MHz and the minimum frequency is 0.593 MHz).
3. This parameter is dependent on the csb_clk speed (that is, for a csb_clk of 133 MHz, the delay is 60 ns).

This figure shows the MII management AC timing diagram.

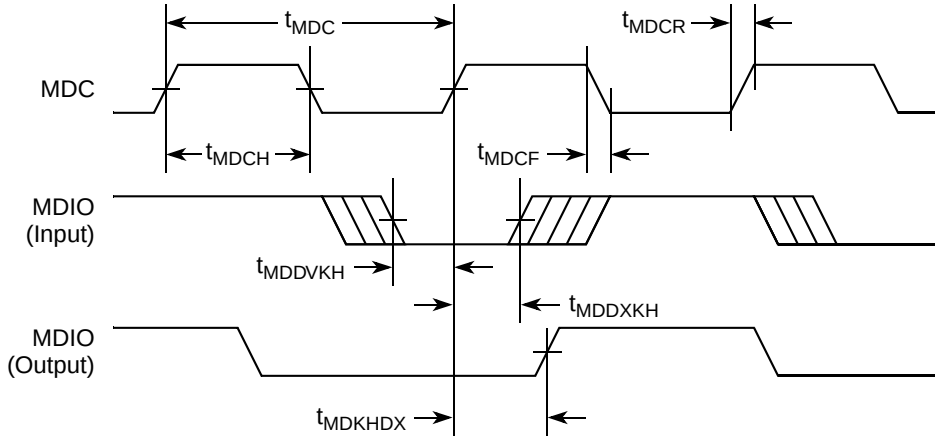


Figure 16. MII Management Interface Timing Diagram

9.4 1588 Timer Specifications

This section describes the DC and AC electrical specifications for the 1588 timer.

9.4.1 1588 Timer DC Specifications

This table provides the 1588 timer DC specifications.

Table 32. GPIO DC Electrical Characteristics

Characteristic	Symbol	Condition	Min	Max	Unit
Output high voltage	V_{OH}	I_{OH} = –8.0 mA	2.4	—	V
Output low voltage	V_{OL}	I_{OL} = 8.0 mA	—	0.5	V
Output low voltage	V_{OL}	I_{OL} = 3.2 mA	—	0.4	V
Input high voltage	V_{IH}	—	2.0	NVDD + 0.3	V
Input low voltage	V_{IL}	—	–0.3	0.8	V
Input current	I_{IN}	0 V ≤ V_{IN} ≤ NVDD	—	± 5	μA

9.4.2 1588 Timer AC Specifications

This table provides the 1588 timer AC specifications.

Table 33. 1588 Timer AC Specifications

Parameter	Symbol	Min	Max	Unit	Note
Timer clock cycle time	t_{TMRCK}	0	70	MHz	1
Input setup to timer clock	t_{TMRCKS}	—	—	—	2, 3
Input hold from timer clock	t_{TMRCKH}	—	—	—	2, 3
Output clock to output valid	t_{GCLKNV}	0	6	ns	
Timer alarm to output valid	t_{TMRAL}	—	—	—	2

Table 35. SGMII DC Transmitter Electrical Characteristics

Parameter	Symbol	Min	Typ	Max	Unit	Note
Supply Voltage	XCOREVDD	0.95	1.0	1.05	V	—
Output high voltage	VOH	—	—	$XCOREVDD_{-Typ}/2 + \lvert V_{OD}\rvert_{-max}/2$	mV	1
Output low voltage	VOL	$XCOREVDD_{-Typ}/2 - \lvert V_{OD}\rvert_{-max}/2$	—	—	mV	1
Output ringing	V_{RING}	—	—	10	%	—
Output differential voltage[2, 3, 5]	$\lvert V_{OD}\rvert$	323	500	725	mV	Equalization setting: 1.0x
		296	459	665		Equalization setting: 1.09x
		269	417	604		Equalization setting: 1.2x
		243	376	545		Equalization setting: 1.33x
		215	333	483		Equalization setting: 1.5x
		189	292	424		Equalization setting: 1.71x
		162	250	362		Equalization setting: 2.0x
Output offset voltage	V_{OS}	425	500	575	mV	1, 4
Output impedance (single-ended)	R_O	40	—	60	Ω	—
Mismatch in a pair	ΔR_O	—	—	10	%	—
Change in V_{OD} between “0” and “1”	$\Delta \lvert V_{OD}\rvert$	—	—	25	mV	—
Change in V_{OS} between “0” and “1”	ΔV_{OS}	—	—	25	mV	—
Output current on short to GND	I_{SA}, I_{SB}	—	—	40	mA	—

Note:

1. This will not align to DC-coupled SGMII. $XCOREVDD_{-Typ}$=1.0V.
2. $\lvert V_{OD}\rvert = \lvert V_{TXn} - V_{\overline{TXn}}\rvert$. $\lvert V_{OD}\rvert$ is also referred as output differential peak voltage. $V_{TX-DIFFp-p} = 2*\lvert V_{OD}\rvert$.
3. The $\lvert V_{OD}\rvert$ value shown in the table assumes the following transmit equalization setting in the TXEQA (for SerDes lane A) or TXEQE (for SerDes lane E) bit field of MPC8315E’s SerDes Control Register 0:
   - The LSbits (bit [1:3]) of the above bit field is set based on the equalization setting shown in table.
4. V_{OS} is also referred to as output common mode voltage.
5. The $\lvert V_{OD}\rvert$ value shown in the Typ column is based on the condition of $XCOREVDD_{-Typ}$=1.0V, no common mode offset variation (V_{OS} = 500 mV), SerDes transmitter is terminated with 100-Ω differential load between TX[n] and $\overline{TX}$[n].

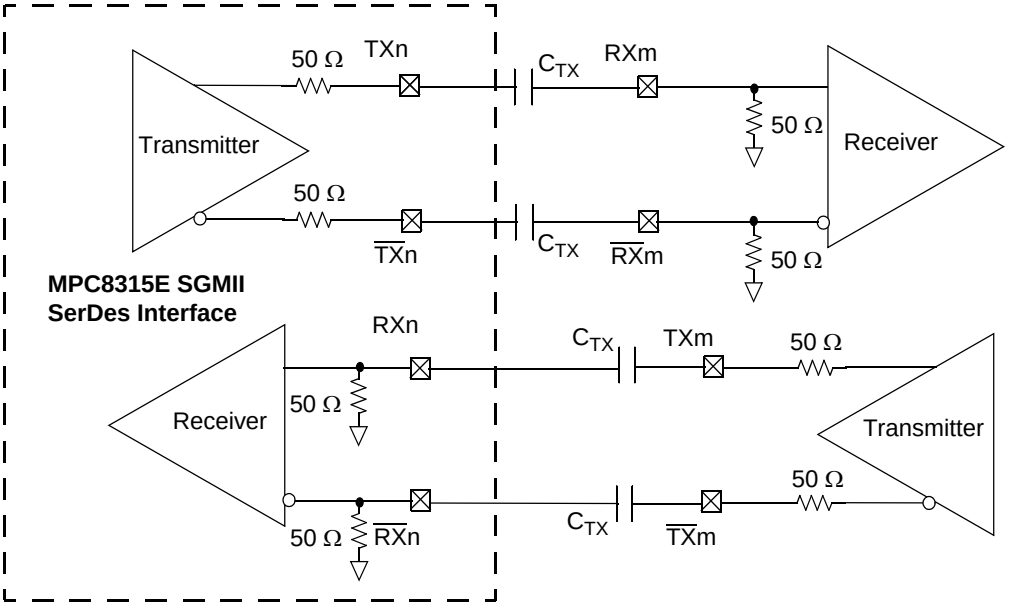


Figure 17. 4-Wire AC-Coupled SGMII Serial Link Connection Example

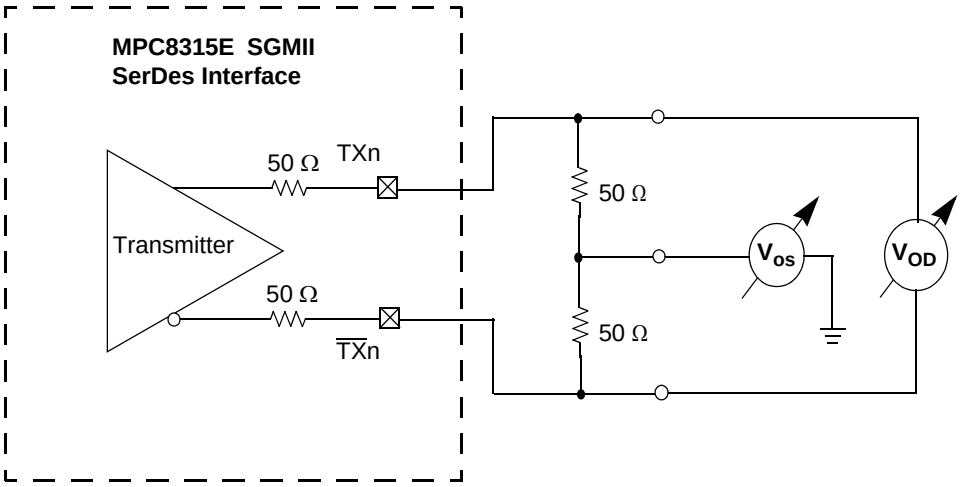


Figure 18. SGMII Transmitter DC Measurement Circuit

Table 36. SGMII DC Receiver Electrical Characteristics

Parameter		Symbol	Min	Typ	Max	Unit	Note
Supply Voltage		XCOREVDD	0.95	1.0	1.05	V	—
DC Input voltage range		—	N/A			—	1
Input differential voltage	EQ = 0	$V_{RX\_DIFFp-p}$	100	—	1200	mV	2, 4
	EQ = 1		175	—			
Loss of signal threshold	EQ = 0	VLOS	30	—	100	mV	3, 4
	EQ = 1		65	—	175		

Table 36. SGMII DC Receiver Electrical Characteristics (continued)

Parameter	Symbol	Min	Typ	Max	Unit	Note
Input AC common mode voltage	$V_{CM\_ACp\text{-}p}$	—	—	100	mV	5
Receiver differential input impedance	Z_{RX_DIFF}	80	100	120	Ω	—
Receiver common mode input impedance	Z_{RX_CM}	20	—	35	Ω	—
Common mode input voltage	V_{CM}	—	$V_{xcorevss}$	—	V	6

Note:
1. Input must be externally AC-coupled.
2. $V_{RX\_DIFFp\text{-}p}$ is also referred to as peak to peak input differential voltage
3. The concept of this parameter is equivalent to the Electrical Idle Detect Threshold parameter in PCI Express. Refer to PCI Express Differential Receiver (RX) Input Specifications section for further explanation.
4. The EQ shown in the table refers to the RXEQA or RXEQE bit field of MPC8315E's SerDes Control Register 0.
5. $V_{CM\_ACp\text{-}p}$ is also referred to as peak to peak AC common mode voltage.
6. On-chip termination to XCOREVSS.

9.5.4 SGMII AC Timing Specifications

This section describes the SGMII transmit and receive AC timing specifications. Transmitter and receiver characteristics are measured at the transmitter outputs (TX[n] and $\overline{\text{TX}}$[n]) or at the receiver inputs (RX[n] and $\overline{\text{RX}}$[n]) as depicted in Figure 20 respectively.

9.5.4.1 SGMII Transmit AC Timing Specifications

This table provides the SGMII transmit AC timing targets. A source synchronous clock is not provided.

Table 37. SGMII Transmit AC Timing Specifications

At recommended operating conditions with XCOREVDD = 1.0V ± 5%.

Parameter	Symbol	Min	Typ	Max	Unit	Note
Deterministic Jitter	JD	—	—	0.17	UI p-p	—
Total Jitter	JT	—	—	0.35	UI p-p	—
Unit Interval	UI	799.92	800	800.08	ps	—
V_{OD} fall time (80%-20%)	tfall	50	—	120	ps	—
V_{OD} rise time (20%-80%)	t_{rise}	50	—	120	ps	—

Note:
1. Each UI is 800 ps ± 100 ppm.

9.5.4.2 SGMII Receive AC Timing Specifications

This table provides the SGMII receive AC timing specifications. Source synchronous clocking is not supported. Clock is recovered from the data. Figure 19 shows the SGMII Receiver Input Compliance Mask eye diagram.

Table 38. SGMII Receive AC Timing Specifications

At recommended operating conditions with XCOREVDD = 1.0V ± 5%.

Parameter	Symbol	Min	Typ	Max	Unit	Note
Deterministic Jitter Tolerance	JD	0.37	—	—	UI p-p	1
Combined Deterministic and Random Jitter Tolerance	JDR	0.55	—	—	UI p-p	1
Sinusoidal Jitter Tolerance	JSIN	0.1	—	—	UI p-p	1
Total Jitter Tolerance	JT	0.65	—	—	UI p-p	1
Bit Error Ratio	BER	—	—	10^{-12}		—
Unit Interval	UI	799.92	800	800.08	ps	2
AC Coupling Capacitor	C_{TX}	5	—	200	nF	3

Note:

1. Measured at receiver.
2. Each UI is 800 ps ± 100 ppm.
3. The external AC coupling capacitor is required. It's recommended to be placed near the device transmitter outputs.
4. Refer to RapidIO™ 1x/4x LP Serial Physical Layer Specification for interpretation of jitter specifications.

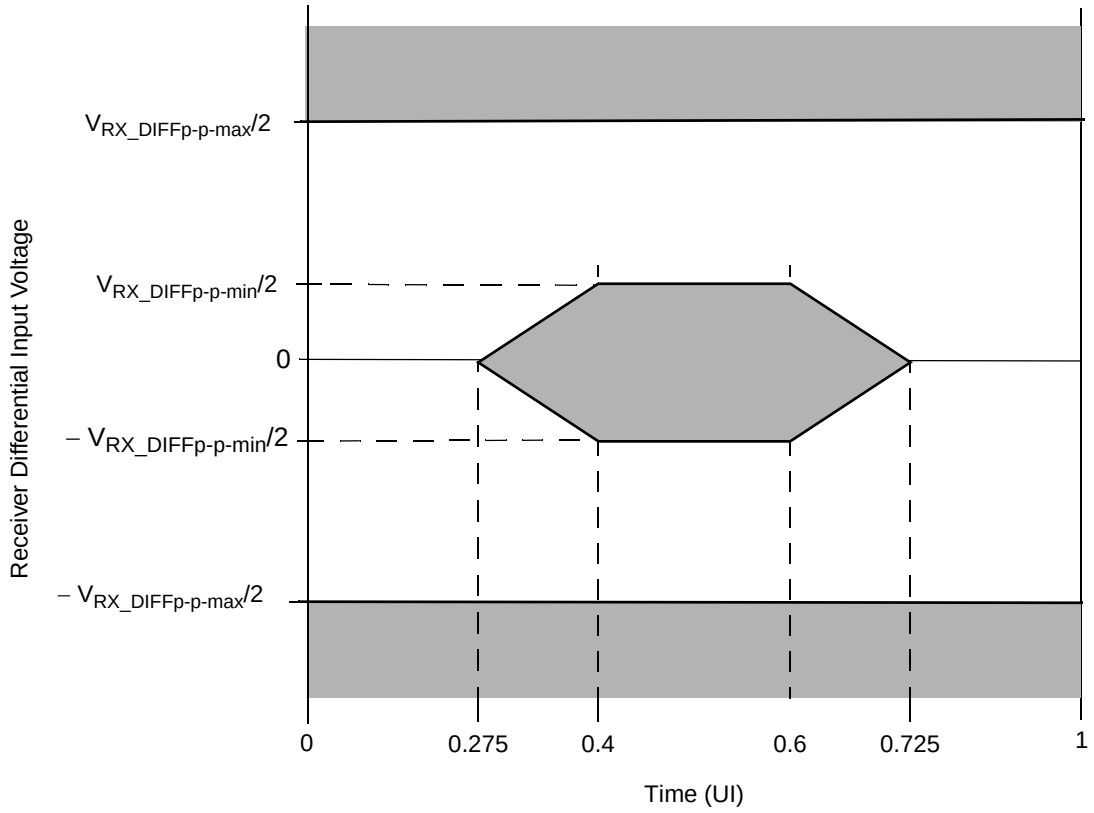


Figure 19. SGMII Receiver Input Compliance Mask

Figure 24 through Figure 26 show the local bus signals.

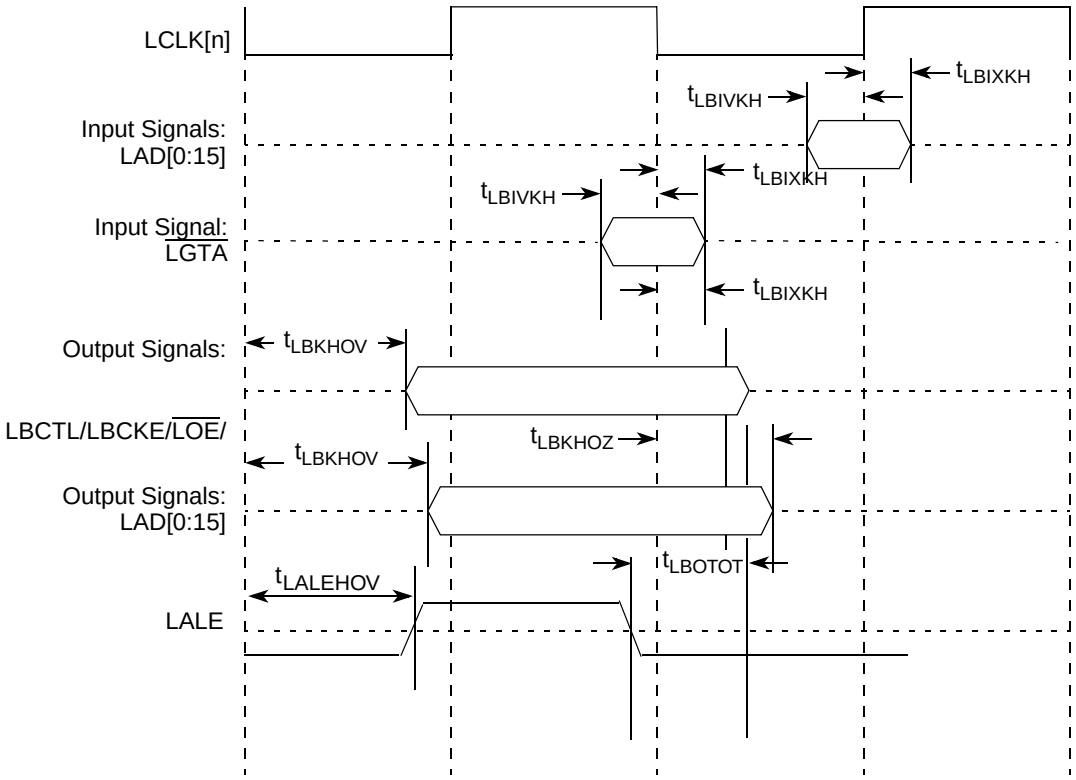


Figure 24. Local Bus Signals, Nonspecial Signals Only

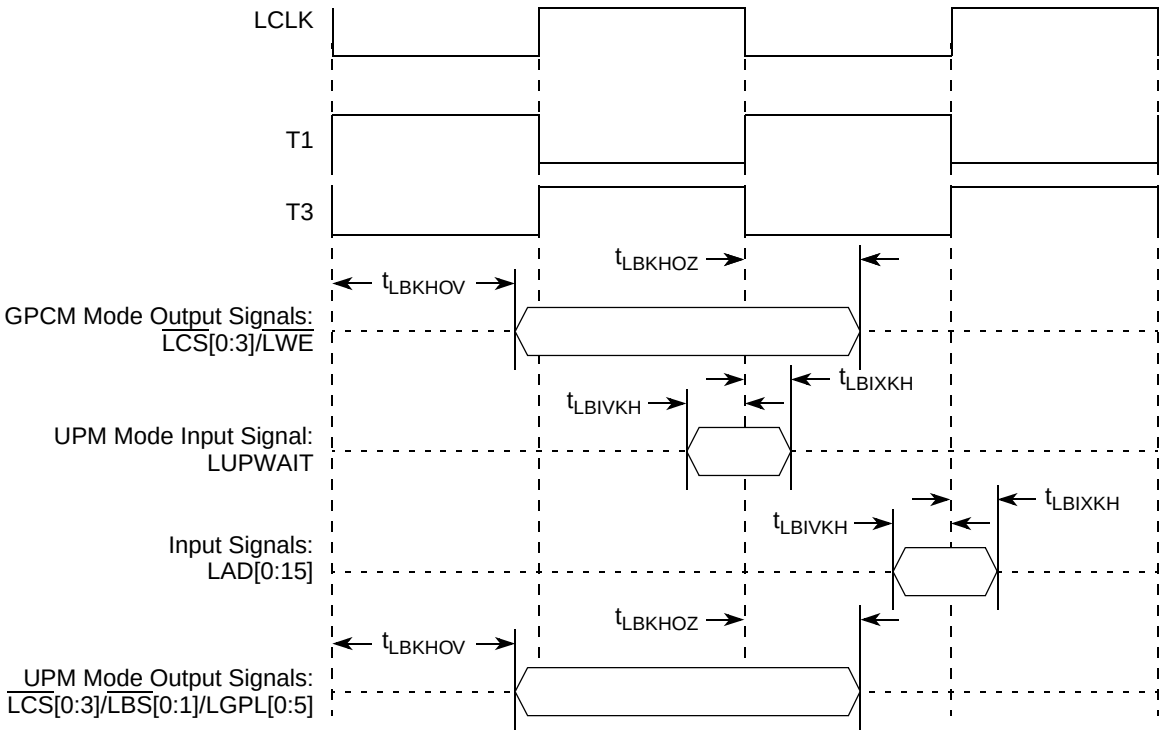


Figure 25. Local Bus Signals, GPCM/UPM Signals for LCRR[CLKDIV] = 2

Table 50. PCI AC Timing Specifications at 66 MHz (continued)

Parameter	Symbol [1]	Min	Max	Unit	Note
Input hold from clock	t_{PCIXKH}	0	—	ns	2, 4

Note:

1. Note that the symbols used for timing specifications herein follow the pattern of $t_{\text{(first two letters of functional block)(signal)(state)(reference)(state)}}$ for inputs and $t_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$ for outputs. For example, t_{PCIVKH} symbolizes PCI timing (PC) with respect to the time the input signals (I) reach the valid state (V) relative to the PCI_SYNC_IN clock, t_{SYS}, reference (K) going to the high (H) state or setup time. Also, t_{PCRHFV} symbolizes PCI timing (PC) with respect to the time hard reset (R) went high (H) relative to the frame signal (F) going to the valid (V) state.
2. See the timing measurement conditions in the *PCI 2.3 Local Bus Specifications*.
3. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
4. Input timings are measured at the pin.

This table shows the PCI AC Timing Specifications at 33 MHz.

Table 51. PCI AC Timing Specifications at 33 MHz

Parameter	Symbol [1]	Min	Max	Unit	Note
Clock to output valid	t_{PCKHOV}	—	11	ns	2
Output hold from clock	t_{PCKHOX}	2	—	ns	2
Clock to output high impedance	t_{PCKHOZ}	—	14	ns	2, 3
Input setup to clock	t_{PCIVKH}	4.0	—	ns	2, 4
Input hold from clock	t_{PCIXKH}	0	—	ns	2, 4

Note:

1. Note that the symbols used for timing specifications follow the pattern of $t_{\text{(first two letters of functional block)(signal)(state)(reference)(state)}}$ for inputs and $t_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$ for outputs. For example, t_{PCIVKH} symbolizes PCI timing (PC) with respect to the time the input signals (I) reach the valid state (V) relative to the PCI_SYNC_IN clock, t_{SYS}, reference (K) going to the high (H) state or setup time. Also, t_{PCRHFV} symbolizes PCI timing (PC) with respect to the time hard reset (R) went high (H) relative to the frame signal (F) going to the valid (V) state.
2. See the timing measurement conditions in the *PCI 2.3 Local Bus Specifications*.
3. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
4. Input timings are measured at the pin.

This figure provides the AC test load for PCI.

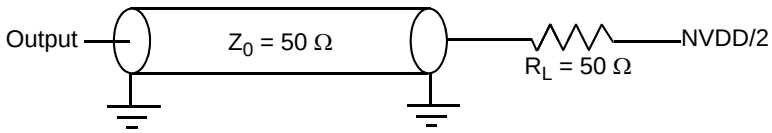


Figure 34. PCI AC Test Load

21.2 TDM AC Electrical Characteristics

This table provides the TDM AC timing specifications.

Table 65. TDM AC Timing specifications

Parameter/Condition	Symbol	Min	Max	Unit
TDMxRCK/TDMxTCK	t_{DM}	20.0	—	ns
TDMxRCK/TDMxTCK high pulse width	t_{DM_HIGH}	8.0	—	ns
TDMxRCK/TDMxTCK low pulse width	t_{DM_LOW}	8.0	—	ns
TDMxRCK/TDMxTCK rise time (20% to 80%)	t_{DMKH}	1.0	4.0	ns
TDMxRCK/TDMxTCK fall time (80% to 20%)	t_{DMKL}	1.0	4.0	ns
TDM all input setup time	t_{DMIVKH}	3.0	—	ns
TDMxRD hold time	$t_{DMRDIXKH}$	3.5	—	ns
TDMxTFS/TDMxRFS input hold time	$t_{DMFSIXKH}$	2.0	—	ns
TDMxTCK High to TDMxTD output active	t_{DM_OUTAC}	4.0	—	ns
TDMxTCK High to TDMxTD output valid	$t_{DMTKHOV}$	—	14.0	ns
TDMxTD hold time	$t_{DMTKHOX}$	2.0	—	ns
TDMxTCK High to TDMxTD output high impedance	t_{DM_OUTHI}	—	10.0	ns
TDMxTFS/TDMxRFS output valid	$t_{DMFSKHOV}$	—	13.5	ns
TDMxTFS/TDMxRFS output hold time	$t_{DMFSKHOX}$	2.5	—	ns

Note:

1. The symbols used for timing specifications herein follow the pattern of $t_{\text{(first two letters of functional block)(signal)(state) (reference)(state)}}$ for inputs and $t_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$ for outputs. For example, $t_{TDMIVKH}$ symbolizes TDM timing (DM) with respect to the time the input signals (I) reach the valid state (V) relative to the TDM Clock, t_{TC}, reference (K) going to the high (H) state or setup time. Also, output signals (O), hold (X).
2. Output values are based on 30 pF capacitive load.
3. Inputs are referenced to the sampling that the TDM is programmed to use. Outputs are referenced to the programming edge they are programmed to use. Use of the rising edge or falling edge as a reference is programmable. TDMxTCK and TDMxRCK are shown using the rising edge.

This figure shows the TDM receive signal timing.

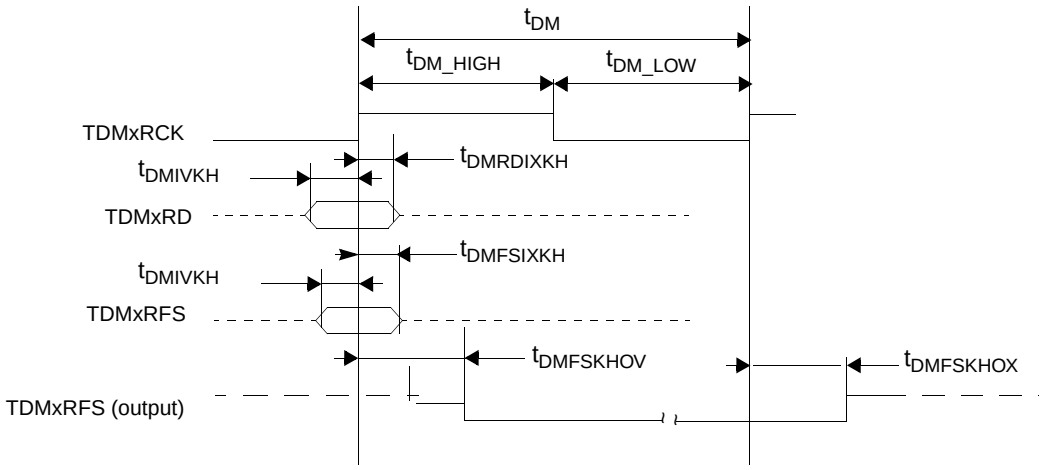


Figure 57. TDM Receive Signals

This figure shows the TDM transmit signal timing.

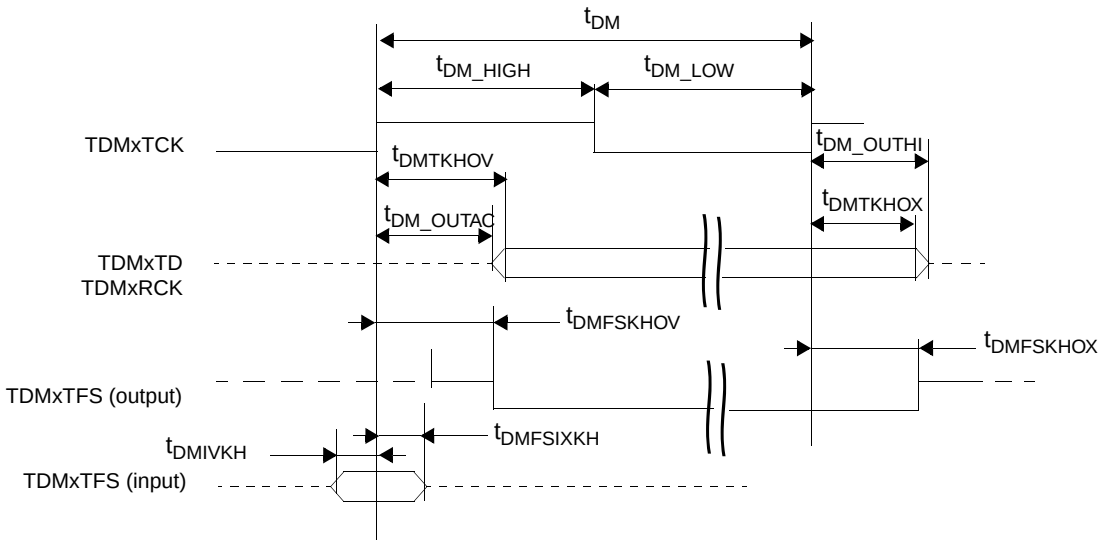


Figure 58. TDM Transmit Signals

22 Package and Pin Listings

This section details package parameters, pin assignments, and dimensions. The MPC8314E is available in a thermally enhanced plastic ball grid array (TEPBGA II), see Section 22.1, "Package Parameters for the MPC8314E TEPBGA II," and Section 22.2, "Mechanical Dimensions of the TEPBGA II," for information on the TEPBGA II.

22.1 Package Parameters for the MPC8314E TEPBGA II

The package parameters are as provided in the following list. The package type is 29 mm × 29 mm, TEPBGA II.

Package outline	29 mm × 29 mm
Interconnects	620
Pitch	1 mm
Module height (typical)	2.23 mm
Solder balls	96.5 Sn/3.5 Ag (VR package)
Ball diameter (typical)	0.6 mm

Table 66. MPC8314E TEPBGA II Pinout Listing

Signal	Package Pin Number	Pin Type	Power Supply	Note
DDR Memory Controller Interface				
MEMC_MDQ[0]	AF16	I/O	GVDD	—
MEMC_MDQ[1]	AE17	I/O	GVDD	—
MEMC_MDQ[2]	AH17	I/O	GVDD	—
MEMC_MDQ[3]	AG17	I/O	GVDD	—
MEMC_MDQ[4]	AG18	I/O	GVDD	—
MEMC_MDQ[5]	AH18	I/O	GVDD	—
MEMC_MDQ[6]	AD18	I/O	GVDD	—
MEMC_MDQ[7]	AF19	I/O	GVDD	—
MEMC_MDQ[8]	AH19	I/O	GVDD	—
MEMC_MDQ[9]	AD19	I/O	GVDD	—
MEMC_MDQ[10]	AG20	I/O	GVDD	—
MEMC_MDQ[11]	AH20	I/O	GVDD	—
MEMC_MDQ[12]	AH21	I/O	GVDD	—
MEMC_MDQ[13]	AE21	I/O	GVDD	—
MEMC_MDQ[14]	AH22	I/O	GVDD	—
MEMC_MDQ[15]	AD21	I/O	GVDD	—
MEMC_MDQ[16]	AG10	I/O	GVDD	—
MEMC_MDQ[17]	AH9	I/O	GVDD	—
MEMC_MDQ[18]	AH8	I/O	GVDD	—
MEMC_MDQ[19]	AD11	I/O	GVDD	—
MEMC_MDQ[20]	AH7	I/O	GVDD	—
MEMC_MDQ[21]	AG7	I/O	GVDD	—
MEMC_MDQ[22]	AF8	I/O	GVDD	—
MEMC_MDQ[23]	AD10	I/O	GVDD	—
MEMC_MDQ[24]	AE9	I/O	GVDD	—
MEMC_MDQ[25]	AH6	I/O	GVDD	—
MEMC_MDQ[26]	AH5	I/O	GVDD	—
MEMC_MDQ[27]	AG6	I/O	GVDD	—
MEMC_MDQ[28]	AH4	I/O	GVDD	—
MEMC_MDQ[29]	AE6	I/O	GVDD	—
MEMC_MDQ[30]	AD8	I/O	GVDD	—
MEMC_MDQ[31]	AF5	I/O	GVDD	—
MEMC_MDM0	AE18	O	GVDD	—
MEMC_MDM1	AE20	O	GVDD	—
MEMC_MDM2	AE10	O	GVDD	—

Table 66. MPC8314E TEPBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Note
LGPL1/LFALE	AA28	O	$NVDD3_{OFF}$	—
LGPL2/$\overline{\text{LFRE}}$/$\overline{\text{LOE}}$	Y25	O	$NVDD3_{OFF}$	11
LGPL3/$\overline{\text{LFWP}}$	Y24	O	$NVDD3_{OFF}$	—
LGPL4/$\overline{\text{LGTA}}$/LUPWAIT/$\overline{\text{LFRB}}$	AA26	I/O	$NVDD3_{OFF}$	2
LGPL5	AF22	O	$NVDD3_{OFF}$	11
LCLK0	AH25	O	$NVDD3_{OFF}$	10
LCLK1	AD24	O	$NVDD3_{OFF}$	10
DUART				
UART_SOUT1/MSRCID0 (DDR ID)/LSRCID0	C15	O	$NVDD2_{OFF}$	—
UART_SIN1/MSRCID1 (DDR ID)/LSRCID1	B16	I/O	$NVDD2_{OFF}$	—
$\overline{\text{UART\_CTS}}$[1]/MSRCID2 (DDR ID)/LSRCID2	D16	I/O	$NVDD2_{OFF}$	—
$\overline{\text{UART\_RTS}}$[1]/MSRCID3 (DDR ID)/LSRCID3	B17	O	$NVDD2_{OFF}$	—
UART_SOUT2/MSRCID4 (DDR ID)/LSRCID4	A16	O	$NVDD2_{OFF}$	—
UART_SIN2/MDVAL (DDR ID)/LDVAL	C16	I/O	$NVDD2_{OFF}$	—
$\overline{\text{UART\_CTS}}$[2]	A17	I	$NVDD2_{OFF}$	—
$\overline{\text{UART\_RTS}}$[2]	A18	O	$NVDD2_{OFF}$	—
I^2C interface				
IIC_SDA/$\overline{\text{CKSTOP\_OUT}}$	N1	I/O	$NVDD4_{OFF}$	2
IIC_SCL/$\overline{\text{CKSTOP\_IN}}$	N2	I/O	$NVDD4_{OFF}$	2
Interrupts				
$\overline{\text{MCP\_OUT}}$	W1	O	$NVDD1_{OFF}$	2
$\overline{\text{IRQ}}$[0]/$\overline{\text{MCP\_IN}}$	Y3	I	$NVDD1_{OFF}$	—
$\overline{\text{IRQ}}$[1]	E1	I	$NVDD1_{ON}$	—
$\overline{\text{IRQ}}$[2]	A7	I	$NVDD1_{ON}$	—
$\overline{\text{IRQ}}$[3]	AA1	I	$NVDD1_{OFF}$	—
$\overline{\text{IRQ}}$[4]	Y5	I	$NVDD1_{OFF}$	—
$\overline{\text{IRQ}}$[5]/$\overline{\text{CORE\_SRESET\_IN}}$	AA2	I	$NVDD1_{OFF}$	—
$\overline{\text{IRQ}}$[6] /$\overline{\text{CKSTOP\_OUT}}$	AA4	I/O	$NVDD1_{OFF}$	—
$\overline{\text{IRQ}}$[7]/$\overline{\text{CKSTOP\_IN}}$	AA5	I	$NVDD1_{OFF}$	—
Configuration				
$\overline{\text{CFG\_CLKIN\_DIV}}$	A5	I	$NVDD1_{ON}$	11
EXT_PWR_CTRL	D3	O	$NVDD1_{ON}$	11
PMC_PWR_OK	D4	I	—	11

Table 66. MPC8314E TEPBGA II Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Note
GPIO_1/DMA_DACK1/GTM1_TIN2/GTM2_TIN1	A4	I/O	$NVDD1_{ON}$	—
GPIO_2/DMA_DONE1/GTM1_TGATE2/GTM2_TGATE1	K3	I/O	$NVDD4_{OFF}$	—
GPIO_3/GTM1_TIN3/GTM2_TIN4	K1	I/O	$NVDD4_{OFF}$	—
GPIO_4/GTM1_TGATE3/GTM2_TGATE4	K2	I/O	$NVDD4_{OFF}$	—
GPIO_5/GTM1_TOUT3/GTM2_TOUT1	L5	I/O	$NVDD4_{OFF}$	—
GPIO_6/GTM1_TIN4/GTM2_TIN3	L3	I/O	$NVDD4_{OFF}$	—
GPIO_7/GTM1_TGATE4/GTM2_TGATE3	L1	I/O	$NVDD4_{OFF}$	—
GPIO_8/USBDR_DRIVE_VBUS/GTM1_TIN1/GTM2_TIN2	M1	I/O	$NVDD4_{OFF}$	—
GPIO_9/USBDR_PWRFAULT/GTM1_TGATE1/GTM2_TGATE2	M2	I/O	$NVDD4_{OFF}$	—
GPIO_10/USBDR_PCTL0/GTM1_TOUT2/GTM2_TOUT1	M5	I/O	$NVDD4_{OFF}$	—
GPIO_11/USBDR_PCTL1/GTM1_TOUT4/GTM2_TOUT3	M4	I/O	$NVDD4_{OFF}$	—
SPI				
SPIMOSI/GPIO_15	W3	I/O	$NVDD1_{OFF}$	—
SPIMISO/GPIO_16	W4	I/O	$NVDD1_{OFF}$	—
SPICLK	Y1	I/O	$NVDD1_{OFF}$	—
SPISEL/GPIO_17	W2	I/O	$NVDD1_{OFF}$	—
Power and Ground Supplies				
GVDD	Y11, Y12, Y14, Y15, Y17, AC8, AC11, AC14, AC17, AD6, AD9, AD17, AE8, AE13, AE19, AF10, AF15, AF21, AG2, AG3, AG8, AG13, AG19, AH2	I	—	—
$LVDD1_{OFF}$	H6, J3, L6, L9, M9	I	—	—
$LVDD2_{ON}$	C11, D9, E10, F11, J12	I	—	—
$NVDD1_{OFF}$	U9, V9, W10, Y4, Y6, AA3, AB4	I	—	—
$NVDD1_{ON}$	B1, B2, C1, D5, E7, F5, F9, J11, K10	I	—	—
$NVDD2_{OFF}$	B22, B27, C19, E16, F15, F18, F21, F25, H25, J17, J18, J23, L20, M20	I	—	—
$NVDD2_{ON}$	L26, N19	I	—	—
$NVDD3_{OFF}$	U20, V20, V23, V26, W19, Y18, Y26, AA23, AA25, AC20, AC25, AD23, AE25, AG25, AG27, T27, U27	I	—	—
$NVDD4_{OFF}$	K4, L2, M6, N10	I	—	—

This circuit is intended to filter noise in the PLLs resonant frequency range from a 500 kHz to 10 MHz range. It should be built with surface mount capacitors with minimum Effective Series Inductance (ESL). Consistent with the recommendations of Dr. Howard Johnson in *High Speed Digital Design: A Handbook of Black Magic* (Prentice Hall, 1993), multiple small capacitors of equal value are recommended over a single large value capacitor.

Each circuit should be placed as close as possible to the specific AV_{DD} pin being supplied to minimize noise coupled from nearby circuits. It should be possible to route directly from the capacitors to the AV_{DD} pin, which is on the periphery of package, without the inductance of vias. Note that the RC filter results in lower voltage level on AVDD. This does not imply that the DC specification can be relaxed.

This figure shows the PLL power supply filter circuit.

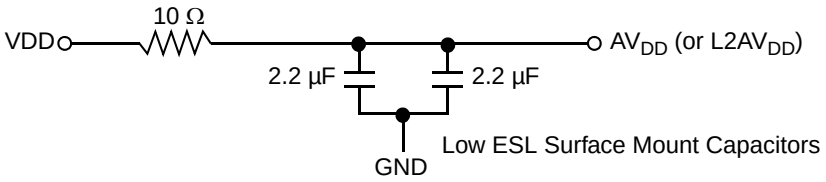


Figure 61. PLL Power Supply Filter Circuit

25.3 Decoupling Recommendations

Due to large address and data buses, and high operating frequencies, the device can generate transient power surges and high frequency noise in its power supply, especially while driving large capacitive loads. This noise must be prevented from reaching other components in the MPC8314E system, and the MPC8314E itself requires a clean, tightly regulated source of power. Therefore, it is recommended that the system designer place at least one decoupling capacitor at each VDD, NVDD, GVDD, and LVDD pins of the device. These decoupling capacitors should receive their power from separate VDD, NVDD, GVDD, LVDD, and GND power planes in the PCB, utilizing thick and short traces to minimize inductance. Capacitors may be placed directly under the device using a standard escape pattern. Others may surround the part.

These capacitors should have a value of 0.01 or 0.1 µF. Only ceramic SMT (surface mount technology) capacitors should be used to minimize lead inductance, preferably 0402 or 0603 sizes.

In addition, it is recommended that there be several bulk storage capacitors distributed around the PCB, feeding the VDD, NVDD, GVDD, and LVDD planes, to enable quick recharging of the smaller chip capacitors. These bulk capacitors should have a low ESR (equivalent series resistance) rating to ensure the quick response time necessary. They should also be connected to the power and ground planes through two vias to minimize inductance. Suggested bulk capacitors—100–330 µF (AVX TPS tantalum or Sanyo OSCON).

25.4 Connection Recommendations

To ensure reliable operation, it is highly recommended to connect unused inputs to an appropriate signal level. Unused active low inputs should be tied to NVDD, GVDD, or LVDD as required. Unused active high inputs should be connected to GND. All NC (no-connect) signals must remain unconnected.

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